MCP1700

Low Quiescent Current LDO

Features

• 1.6 µA Typical Quiescent Current
• Input Operating Voltage Range: 2.3V to 6.0V
• Output Voltage Range: 1.2V to 5.0V
• 250 mA Output Current for output voltages ≥ 2.5V
• 200 mA Output Current for output voltages < 2.5V
• Low Dropout (LDO) voltage
  - 178 mV typical @ 250 mA for V_{OUT} = 2.8V
• 0.4% Typical Output Voltage Tolerance
• Standard Output Voltage Options:
  - 1.2V, 1.8V, 2.5V, 3.0V, 3.3V, 5.0V
• Stable with 1.0 µF Ceramic Output capacitor
• Short-Circuit Protection
• Overtemperature Protection

Applications

• Battery-powered Devices
• Battery-powered Alarm Circuits
• Smoke Detectors
• CO₂ Detectors
• Pagers and Cellular Phones
• Smart Battery Packs
• Low Quiescent Current Voltage Reference
• PDAs
• Digital Cameras
• Microcontroller Power

Related Literature

• AN765, “Using Microchip’s Micropower LDOs”, DS00765, Microchip Technology Inc., 2002
• AN766, “Pin-Compatible CMOS Upgrades to BiPolar LDOs”, DS00766, Microchip Technology Inc., 2002

Description

The MCP1700 is a family of CMOS low dropout (LDO) voltage regulators that can deliver up to 250 mA of current while consuming only 1.6 µA of quiescent current (typical). The input operating range is specified from 2.3V to 6.0V, making it an ideal choice for two and three primary cell battery-powered applications, as well as single cell Li-Ion-powered applications.

The MCP1700 is capable of delivering 250 mA with only 178 mV of input to output voltage differential (V_{OUT} = 2.8V). The output voltage tolerance of the MCP1700 is typically ±0.4% at +25°C and ±3% maximum over the operating junction temperature range of -40°C to +125°C.

Output voltages available for the MCP1700 range from 1.2V to 5.0V. The LDO output is stable when using only 1 µF output capacitance. Ceramic, tantalum or aluminum electrolytic capacitors can all be used for input and output. Overcurrent limit and overtemperature shutdown provide a robust solution for any application.

Package options include the SOT23, SOT89-3 and TO92.

Package Types

<table>
<thead>
<tr>
<th>3-Pin SOT23-A</th>
<th>3-Pin SOT-89</th>
<th>3-Pin TO-92</th>
</tr>
</thead>
<tbody>
<tr>
<td>V_IN</td>
<td>V_IN</td>
<td>V_IN</td>
</tr>
<tr>
<td>GND V_OUT</td>
<td>GND V_IN V_OUT</td>
<td>GND V_IN V_OUT</td>
</tr>
</tbody>
</table>

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MCP1700

Functional Block Diagrams

![Functional Block Diagram of MCP1700](image)

Typical Application Circuits

![Typical Application Circuit of MCP1700](image)
## 1.0 ELECTRICAL CHARACTERISTICS

### Absolute Maximum Ratings †

- **VDD**: +6.5V
- All inputs and outputs w.r.t. (VSS-0.3V) to (VIN+0.3V)
- Peak Output Current: Internally Limited
- Storage temperature: -65°C to +150°C
- Maximum Junction Temperature: 150°C
- Operating Junction Temperature: -40°C to +125°C
- ESD protection on all pins (HBM;MM): ≥ 4k V; ≥ 400V

† Notice: Stresses above those listed under “Maximum Ratings” may cause permanent damage to the device. This is a stress rating only and functional operation of the device at those or any other conditions above those indicated in the operational listings of this specification is not implied. Exposure to maximum rating conditions for extended periods may affect device reliability.

### DC CHARACTERISTICS

**Electrical Characteristics:** Unless otherwise specified, all limits are established for V IN = VR + 1, I LOAD = 100 µA, C OUT = 1 µF (X5R), C IN = 1 µF (X5R), T A = +25°C.

**Boldface type applies for junction temperatures, T J (Note 6) of -40°C to +125°C.**

<table>
<thead>
<tr>
<th>Parameters</th>
<th>Sym</th>
<th>Min</th>
<th>Typ</th>
<th>Max</th>
<th>Units</th>
<th>Conditions</th>
</tr>
</thead>
<tbody>
<tr>
<td>Input / Output Characteristics</td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>Input Operating Voltage</td>
<td>VIN</td>
<td>2.3</td>
<td>—</td>
<td>6.0</td>
<td>V</td>
<td>Note 1</td>
</tr>
<tr>
<td>Input Quiescent Current</td>
<td>I q</td>
<td>—</td>
<td>1.6</td>
<td>4</td>
<td>µA</td>
<td>I L = 0 mA, V IN = VR +1V</td>
</tr>
<tr>
<td>Maximum Output Current</td>
<td>I OUT mA</td>
<td>250</td>
<td>200</td>
<td>—</td>
<td>mA</td>
<td>For VR ≥ 2.5V</td>
</tr>
<tr>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td>For VR &lt; 2.5V</td>
</tr>
<tr>
<td>Output Short Circuit Current</td>
<td>I OUT SC</td>
<td>—</td>
<td>408</td>
<td>—</td>
<td>mA</td>
<td>V IN = VR +1V, V OUT = GND, Current (peak current) measured 10 ms after short is applied.</td>
</tr>
<tr>
<td>Output Voltage Regulation</td>
<td>V OUT</td>
<td>VR-3.0%</td>
<td>VR-2.0%</td>
<td>VR±0.4%</td>
<td>VR±3.0%</td>
<td>VR+2.0%</td>
</tr>
<tr>
<td>V OUT Temperature Coefficient</td>
<td>TCV OUT</td>
<td>—</td>
<td>50</td>
<td>—</td>
<td>ppm/°C</td>
<td>Note 3</td>
</tr>
<tr>
<td>Line Regulation</td>
<td>ΔV OUT / (V OUTXΔVIN)</td>
<td>-1.0</td>
<td>±0.75</td>
<td>+1.0</td>
<td>%/V</td>
<td>(VR+1)V ≤ VIN ≤ 6V</td>
</tr>
<tr>
<td>Load Regulation</td>
<td>ΔV OUT / V OUT</td>
<td>-1.5</td>
<td>±1.0</td>
<td>+1.5</td>
<td>%</td>
<td>I L = 0.1 mA to 250 mA for VR ≥ 2.5V</td>
</tr>
<tr>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td>I L = 0.1 mA to 200 mA for VR &lt; 2.5V</td>
</tr>
<tr>
<td>Dropout Voltage</td>
<td>V R &gt; 2.5V</td>
<td>V IN-V OUT</td>
<td>—</td>
<td>178</td>
<td>350</td>
<td>mV</td>
</tr>
<tr>
<td>Dropout Voltage</td>
<td>V R &lt; 2.5V</td>
<td>V IN-V OUT</td>
<td>—</td>
<td>150</td>
<td>350</td>
<td>mV</td>
</tr>
<tr>
<td>Output Rise Time</td>
<td>T R</td>
<td>—</td>
<td>500</td>
<td>—</td>
<td>µs</td>
<td>10% VR to 90% VR</td>
</tr>
</tbody>
</table>

Note 1: The minimum V IN must meet two conditions: V IN ≥ 2.3V and V IN ≥ (VR + 3.0%) +V DROPOUT.

2: VR is the nominal regulator output voltage. For example: VR = 1.2V, 1.5V, 1.8V, 2.5V, 2.8V, 3.0V, 3.3V, 4.0V, 5.0V. The input voltage (V IN = VR + 1.0V); I OUT = 100 µA.

3: TCV OUT = (V OUT-HIGH - V OUT-LOW) *10⁶ / (VR * ΔTemperature), V OUT-HIGH = highest voltage measured over the temperature range. V OUT-LOW = lowest voltage measured over the temperature range.

4: Load regulation is measured at a constant junction temperature using low duty cycle pulse testing. Changes in output voltage due to heating effects are determined using thermal regulation specification TCV OUT.

5: Dropout voltage is defined as the input to output differential at which the output voltage drops 2% below its measured value with a VR + 1V differential applied.

6: The maximum allowable power dissipation is a function of ambient temperature, the maximum allowable junction temperature and the thermal resistance from junction to air (i.e., T A, T J, θ JA). Exceeding the maximum allowable power dissipation will cause the device operating junction temperature to exceed the maximum 150°C rating. Sustained junction temperatures above 150°C can impact the device reliability.

7: The junction temperature is approximated by soaking the device under test at an ambient temperature equal to the desired Junction temperature. The test time is small enough such that the rise in the Junction temperature over the ambient temperature is not significant.
TEMPERATURE SPECIFICATIONS

**Electrical Characteristics:** Unless otherwise specified, all limits are established for \( V_{\text{IN}} = V_R + 1, I_{\text{LOAD}} = 100 \mu A, C_{\text{OUT}} = 1 \mu F \) (X5R), \( C_{\text{IN}} = 1 \mu F \) (X5R), \( T_A = +25^\circ C \).

**Boldface type applies for junction temperatures, \( T_J \) (Note 6) of -40°C to +125°C.**

<table>
<thead>
<tr>
<th>Parameters</th>
<th>Sym</th>
<th>Min</th>
<th>Typ</th>
<th>Max</th>
<th>Units</th>
<th>Conditions</th>
</tr>
</thead>
<tbody>
<tr>
<td>Output Noise</td>
<td>( e_N )</td>
<td>—</td>
<td>3</td>
<td>—</td>
<td>( \mu V/\text{Hz}^{1/2} )</td>
<td>( I_L = 100 \text{ mA}, f = 1 \text{ kHz}, C_{\text{OUT}} = 1 \mu F )</td>
</tr>
<tr>
<td>Power Supply Ripple Rejection Ratio</td>
<td>PSRR</td>
<td>—</td>
<td>44</td>
<td>—</td>
<td>dB</td>
<td>( f = 100 \text{ Hz}, C_{\text{OUT}} = 1 \mu F, I_L = 50 \text{ mA}, V_{INAC} = 100 \text{ mV pk-pk}, C_{\text{IN}} = 0 \mu F, V_R = 1.2V )</td>
</tr>
<tr>
<td>Thermal Shutdown Protection</td>
<td>( T_{SD} )</td>
<td>—</td>
<td>140</td>
<td>—</td>
<td>°C</td>
<td>( V_{IN} = V_R + 1, I_L = 100 \mu A )</td>
</tr>
</tbody>
</table>

**Note 1:** The minimum \( V_{\text{IN}} \) must meet two conditions: \( V_{\text{IN}} \geq 2.3V \) and \( V_{\text{IN}} \geq (V_R + 3.0\%) + V_{\text{DROPOUT}} \).

2: \( V_R \) is the nominal regulator output voltage. For example: \( V_R = 1.2V, 1.5V, 1.8V, 2.5V, 2.8V, 3.0V, 3.3V, 4.0V, 5.0V \). The input voltage \( V_{IN} = V_R + 1.0V \); \( I_{OUT} = 100 \mu A \).

3: \( TCV_{OUT} = (V_{OUT-HIGH} - V_{OUT-LOW}) \times 10^6 / (V_R \times \Delta Temperature) \). \( V_{OUT-HIGH} \) = highest voltage measured over the temperature range. \( V_{OUT-LOW} \) = lowest voltage measured over the temperature range.

4: Load regulation is measured at a constant junction temperature using low duty cycle pulse testing. Changes in output voltage due to heating effects are determined using thermal regulation specification \( TCV_{OUT} \).

5: Dropout voltage is defined as the input to output differential at which the output voltage drops 2% below its measured value with a \( V_R + 1V \) differential applied.

6: The maximum allowable power dissipation is a function of ambient temperature, the maximum allowable junction temperature and the thermal resistance from junction to air (i.e., \( T_A, T_J, \theta_{JA} \)). Exceeding the maximum allowable power dissipation will cause the device operating junction temperature to exceed the maximum 150°C rating. Sustained junction temperatures above 150°C can impact the device reliability.

7: The junction temperature is approximated by soaking the device under test at an ambient temperature equal to the desired Junction temperature. The test time is small enough such that the rise in the Junction temperature over the ambient temperature is not significant.

**TEMPERATURE SPECIFICATIONS**

<table>
<thead>
<tr>
<th>Parameters</th>
<th>Sym</th>
<th>Min</th>
<th>Typ</th>
<th>Max</th>
<th>Units</th>
<th>Conditions</th>
</tr>
</thead>
<tbody>
<tr>
<td>Specified Temperature Range</td>
<td>( T_A )</td>
<td>-40</td>
<td>+125</td>
<td>°C</td>
<td></td>
<td></td>
</tr>
<tr>
<td>Operating Temperature Range</td>
<td>( T_A )</td>
<td>-40</td>
<td>+125</td>
<td>°C</td>
<td></td>
<td></td>
</tr>
<tr>
<td>Storage Temperature Range</td>
<td>( T_A )</td>
<td>-65</td>
<td>+150</td>
<td>°C</td>
<td></td>
<td></td>
</tr>
</tbody>
</table>

**Thermal Package Resistance**

<table>
<thead>
<tr>
<th>Parameters</th>
<th>( \theta_{JA} )</th>
<th>335</th>
<th>—</th>
<th>°C/W</th>
<th>Minimum Trace Width Single Layer Board</th>
</tr>
</thead>
<tbody>
<tr>
<td>——</td>
<td>—</td>
<td>230</td>
<td>—</td>
<td>°C/W</td>
<td>Typical FR4 4-layer Application</td>
</tr>
<tr>
<td>Thermal Resistance, TO-92</td>
<td>( \theta_{JA} )</td>
<td>52</td>
<td>—</td>
<td>°C/W</td>
<td>Typical, 1 square inch of copper</td>
</tr>
<tr>
<td>Thermal Resistance</td>
<td>( \theta_{JA} )</td>
<td>131.9</td>
<td>—</td>
<td>°C/W</td>
<td>EIA/JEDEC JESD51-751-7 4-Layer Board</td>
</tr>
</tbody>
</table>

**Note 1:** The maximum allowable power dissipation is a function of ambient temperature, the maximum allowable junction temperature and the thermal resistance from junction to air (i.e., \( T_A, T_J, \theta_{JA} \)). Exceeding the maximum allowable power dissipation will cause the device operating junction temperature to exceed the maximum 150°C rating. Sustained junction temperatures above 150°C can impact the device reliability.
2.0 TYPICAL PERFORMANCE CURVES

Note: The graphs and tables provided following this note are a statistical summary based on a limited number of samples and are provided for informational purposes only. The performance characteristics listed herein are not tested or guaranteed. In some graphs or tables, the data presented may be outside the specified operating range (e.g., outside specified power supply range) and therefore outside the warranted range.

Note: Unless otherwise indicated: \( V_R = 1.8\text{V}, C_{OUT} = 1 \mu\text{F Ceramic (X5R)}, C_{IN} = 1 \mu\text{F Ceramic (X5R)}, I_L = 100 \mu\text{A}, T_A = +25\degree\text{C}, V_{IN} = V_R +1\text{V} \).

Note: Junction Temperature \( (T_J) \) is approximated by soaking the device under test to an ambient temperature equal to the desired junction temperature. The test time is small enough such that the rise in Junction temperature over the Ambient temperature is not significant.

**FIGURE 2-1: Input Quiescent Current vs. Input Voltage.**

**FIGURE 2-2: Ground Current vs. Load Current.**

**FIGURE 2-3: Quiescent Current vs. Junction Temperature.**

**FIGURE 2-4: Output Voltage vs. Input Voltage \( (V_R = 1.2\text{V}) \).**

**FIGURE 2-5: Output Voltage vs. Input Voltage \( (V_R = 1.8\text{V}) \).**

**FIGURE 2-6: Output Voltage vs. Input Voltage \( (V_R = 2.8\text{V}) \).**
Note: Unless otherwise indicated: $V_R = 1.8V$, $C_{OUT} = 1 \mu F$ Ceramic (X5R), $C_{IN} = 1 \mu F$ Ceramic (X5R), $I_L = 100 \mu A$, $T_A = +25^\circ C$, $V_{IN} = V_R + 1V$. 

**FIGURE 2-7:** Output Voltage vs. Input Voltage ($V_R = 5.0V$).

**FIGURE 2-8:** Output Voltage vs. Load Current ($V_R = 1.2V$).

**FIGURE 2-9:** Output Voltage vs. Load Current ($V_R = 1.8V$).

**FIGURE 2-10:** Output Voltage vs. Load Current ($V_R = 2.8V$).

**FIGURE 2-11:** Output Voltage vs. Load Current ($V_R = 5.0V$).

**FIGURE 2-12:** Dropout Voltage vs. Load Current ($V_R = 2.8V$).
Note: Unless otherwise indicated: $V_R = 1.8V$, $C_{OUT} = 1 \mu F$ Ceramic (X5R), $C_{IN} = 1 \mu F$ Ceramic (X5R), $I_L = 100 \mu A$, $T_A = +25^\circ C$, $V_{IN} = V_R +1V$.

**FIGURE 2-13:** Dropout Voltage vs. Load Current ($V_R = 5.0V$).

**FIGURE 2-14:** Power Supply Ripple Rejection vs. Frequency ($V_R = 1.2V$).

**FIGURE 2-15:** Power Supply Ripple Rejection vs. Frequency ($V_R = 2.8V$).

**FIGURE 2-16:** Noise vs. Frequency.

**FIGURE 2-17:** Dynamic Load Step ($V_R = 1.2V$).

**FIGURE 2-18:** Dynamic Load Step ($V_R = 1.8V$).
Note: Unless otherwise indicated: $V_R = 1.8V$, $C_{OUT} = 1 \mu F$ Ceramic (X5R), $C_{IN} = 1 \mu F$ Ceramic (X5R), $I_L = 100 \mu A$, $T_A = +25^\circ C$, $V_{IN} = V_R +1V$.

**FIGURE 2-19:** Dynamic Load Step ($V_R = 2.8V$).

**FIGURE 2-20:** Dynamic Load Step ($V_R = 1.8V$).

**FIGURE 2-21:** Dynamic Load Step ($V_R = 2.8V$).

**FIGURE 2-22:** Dynamic Load Step ($V_R = 5.0V$).

**FIGURE 2-23:** Dynamic Line Step ($V_R = 2.8V$).

**FIGURE 2-24:** Startup From $V_{IN}$ ($V_R = 1.2V$).
Note: Unless otherwise indicated: $V_R = 1.8V$, $C_{OUT} = 1 \mu F$ Ceramic (X5R), $C_{IN} = 1 \mu F$ Ceramic (X5R), $I_L = 100 \mu A$, $T_A = +25^\circ C$, $V_{IN} = V_R +1V$.

**FIGURE 2-25:** Start-up From $V_{IN}$ ($V_R = 1.8V$).

**FIGURE 2-26:** Start-up From $V_{IN}$ ($V_R = 2.8V$).

**FIGURE 2-27:** Load Regulation vs. Junction Temperature ($V_R = 1.8V$).

**FIGURE 2-28:** Load Regulation vs. Junction Temperature ($V_R = 2.8V$).

**FIGURE 2-29:** Load Regulation vs. Junction Temperature ($V_R = 5.0V$).

**FIGURE 2-30:** Line Regulation vs. Temperature ($V_R = 1.2V, 1.8V, 2.8V$).
3.0 MCP1700 PIN DESCRIPTIONS

The descriptions of the pins are listed in Table 3-1.

### TABLE 3-1: MCP1700 PIN FUNCTION TABLE

<table>
<thead>
<tr>
<th>Pin No.</th>
<th>Pin No.</th>
<th>Pin No.</th>
<th>Name</th>
<th>Function</th>
</tr>
</thead>
<tbody>
<tr>
<td>SOT23-A</td>
<td>SOT89</td>
<td>TO-92</td>
<td></td>
<td></td>
</tr>
<tr>
<td>1</td>
<td>1</td>
<td>1</td>
<td>GND</td>
<td>Ground Terminal</td>
</tr>
<tr>
<td>2</td>
<td>3</td>
<td>3</td>
<td>V_OUT</td>
<td>Regulated Voltage Output</td>
</tr>
<tr>
<td>3</td>
<td>2</td>
<td>2</td>
<td>V_IN</td>
<td>Unregulated Supply Voltage</td>
</tr>
</tbody>
</table>

3.1 Ground Terminal (GND)

Regulator ground. Tie GND to the negative side of the output and the negative side of the input capacitor. Only the LDO bias current (1.6 µA typical) flows out of this pin; there is no high current. The LDO output regulation is referenced to this pin. Minimize voltage drops between this pin and the negative side of the load.

3.2 Regulated Output Voltage (V_OUT)

Connect V_OUT to the positive side of the load and the positive terminal of the output capacitor. The positive side of the output capacitor should be physically located as close to the LDO V_OUT pin as is practical. The current flowing out of this pin is equal to the DC load current.

3.3 Unregulated Input Voltage Pin (V_IN)

Connect V_IN to the input unregulated source voltage. Like all low dropout linear regulators, low source impedance is necessary for the stable operation of the LDO. The amount of capacitance required to ensure low source impedance will depend on the proximity of the input source capacitors or battery type. For most applications, 1 µF of capacitance will ensure stable operation of the LDO circuit. For applications that have load currents below 100 mA, the input capacitance requirement can be lowered. The type of capacitor used can be ceramic, tantalum or aluminum electrolytic. The low ESR characteristics of the ceramic will yield better noise and PSRR performance at high-frequency.
4.0 DETAILED DESCRIPTION

4.1 Output Regulation

A portion of the LDO output voltage is fed back to the internal error amplifier and compared with the precision internal bandgap reference. The error amplifier output will adjust the amount of current that flows through the P-Channel pass transistor, thus regulating the output voltage to the desired value. Any changes in input voltage or output current will cause the error amplifier to respond and adjust the output voltage to the target voltage (refer to Figure 4-1).

4.2 Overcurrent

The MCP1700 internal circuitry monitors the amount of current flowing through the P-Channel pass transistor. In the event of a short-circuit or excessive output current, the MCP1700 will turn off the P-Channel device for a short period, after which the LDO will attempt to restart. If the excessive current remains, the cycle will repeat itself.

4.3 Overtemperature

The internal power dissipation within the LDO is a function of input-to-output voltage differential and load current. If the power dissipation within the LDO is excessive, the internal junction temperature will rise above the typical shutdown threshold of 140°C. At that point, the LDO will shut down and begin to cool to the typical turn-on junction temperature of 130°C. If the power dissipation is low enough, the device will continue to cool and operate normally. If the power dissipation remains high, the thermal shutdown protection circuitry will again turn off the LDO, protecting it from catastrophic failure.

FIGURE 4-1: Block Diagram.
5.0 FUNCTIONAL DESCRIPTION

The MCP1700 CMOS low dropout linear regulator is intended for applications that need the lowest current consumption while maintaining output voltage regulation. The operating continuous load range of the MCP1700 is from 0 mA to 250 mA ($V_R \geq 2.5V$). The input operating voltage range is from 2.3V to 6.0V, making it capable of operating from two, three or four alkaline cells or a single Li-Ion cell battery input.

5.1 Input

The input of the MCP1700 is connected to the source of the P-Channel PMOS pass transistor. As with all LDO circuits, a relatively low source impedance ($10 \Omega$) is needed to prevent the input impedance from causing the LDO to become unstable. The size and type of the capacitor needed depends heavily on the input source type (battery, power supply) and the output current range of the application. For most applications (up to 100 mA), a $1 \mu F$ ceramic capacitor will be sufficient to ensure circuit stability. Larger values can be used to improve circuit AC performance.

5.2 Output

The maximum rated continuous output current for the MCP1700 is 250 mA ($V_R \geq 2.5V$). For applications where $V_R < 2.5V$, the maximum output current is 200 mA.

A minimum output capacitance of $1.0 \mu F$ is required for small signal stability in applications that have up to 250 mA output current capability. The capacitor type can be ceramic, tantalum or aluminum electrolytic. The esr range on the output capacitor can range from 0 $\Omega$ to 2.0 $\Omega$.

5.3 Output Rise time

When powering up the internal reference output, the typical output rise time of 500 $\mu s$ is controlled to prevent overshoot of the output voltage.
6.0 APPLICATION CIRCUITS & ISSUES

6.1 Typical Application

The MCP1700 is most commonly used as a voltage regulator. Its low quiescent current and low dropout voltage make it ideal for many battery-powered applications.

![Typical Application Circuit](image)

**FIGURE 6-1:** Typical Application Circuit.

6.1.1 APPLICATION INPUT CONDITIONS

- **Package Type:** SOT23
- **Input Voltage Range:** 2.3V to 3.2V
- **VIN maximum:** 3.2V
- **VOUT typical:** 1.8V
- **IOUT maximum:** 150 mA

6.2 Power Calculations

6.2.1 POWER DISSIPATION

The internal power dissipation of the MCP1700 is a function of input voltage, output voltage and output current. The power dissipation, as a result of the quiescent current draw, is so low, it is insignificant (1.6 µA x VIN). The following equation can be used to calculate the internal power dissipation of the LDO.

**EQUATION**

\[ P_{LDO} = (V_{IN(MAX)} - V_{OUT(MIN)}) \times I_{OUT(MAX)} \]

where:
- **P_{LDO}** = LDO Pass device internal power dissipation
- **V_{IN(MAX)}** = Maximum input voltage
- **V_{OUT(MIN)}** = LDO minimum output voltage

The maximum continuous operating junction temperature specified for the MCP1700 is +125°C. To estimate the internal junction temperature of the MCP1700, the total internal power dissipation is multiplied by the thermal resistance from junction to ambient (RθJA). The thermal resistance from junction to ambient for the SOT23 pin package is estimated at 230 °C/W.

**EQUATION**

\[ T_{J(MAX)} = P_{TOTAL} \times R_{\theta JA} + T_{AMAX} \]

where:
- **T_{J(MAX)}** = Maximum continuous junction temperature.
- **P_{TOTAL}** = Total device power dissipation.
- **R_{\theta JA}** = Thermal resistance from junction to ambient.
- **T_{AMAX}** = Maximum ambient temperature.

The maximum power dissipation capability for a package can be calculated given the junction-to-ambient thermal resistance and the maximum ambient temperature for the application. The following equation can be used to determine the package maximum internal power dissipation.

**EQUATION**

\[ P_{D(MAX)} = \frac{(T_{J(MAX)} - T_A(MAX))}{R_{\theta JA}} \]

where:
- **P_{D(MAX)}** = Maximum device power dissipation.
- **T_{J(MAX)}** = Maximum continuous junction temperature.
- **T_A(MAX)** = Maximum ambient temperature.
- **R_{\theta JA}** = Thermal resistance from junction to ambient.

**EQUATION**

\[ T_{J(RISE)} = P_{D(MAX)} \times R_{\theta JA} \]

where:
- **T_{J(RISE)}** = Rise in device junction temperature over the ambient temperature.
- **P_{D(MAX)}** = Maximum device power dissipation.
- **R_{\theta JA}** = Thermal resistance from junction to ambient.

**EQUATION**

\[ T_J = T_{J(RISE)} + T_A \]

where:
- **T_J** = Junction Temperature.
- **T_{J(RISE)}** = Rise in device junction temperature over the ambient temperature.
- **T_A** = Ambient temperature.
6.3  Voltage Regulator

Internal power dissipation, junction temperature rise, junction temperature and maximum power dissipation are calculated in the following example. The power dissipation, as a result of ground current, is small enough to be neglected.

6.3.1  POWER DISSIPATION EXAMPLE

Package

Package Type = SOT23
Input Voltage

\[ V_{\text{IN}} = 2.3V \text{ to } 3.2V \]

LDO Output Voltages and Currents

\[ V_{\text{OUT}} = 1.8V \]
\[ I_{\text{OUT}} = 150 \text{ mA} \]

Maximum Ambient Temperature

\[ T_{A(\text{MAX})} = +40^\circ \text{C} \]

Internal Power Dissipation

Internal power dissipation is the product of the LDO output current times the voltage across the LDO (\(V_{\text{IN}}\) to \(V_{\text{OUT}}\)).

\[ P_{\text{LDO(MAX)}} = (V_{\text{IN(MAX)}} - V_{\text{OUT(MIN)}}) \times I_{\text{OUT(MAX)}} \]
\[ P_{\text{LDO}} = (3.2V - (0.97 \times 1.8V)) \times 150 \text{ mA} \]
\[ P_{\text{LDO}} = 218.1 \text{ milli-Watts} \]

Device Junction Temperature Rise

The internal junction temperature rise is a function of internal power dissipation and the thermal resistance from junction to ambient for the application. The thermal resistance from junction to ambient (\(R_{\theta \text{JA}}\)) is derived from an EIA/JEDEC standard for measuring thermal resistance for small surface mount packages. The EIA/JEDEC specification is JESD51-7, "High Effective Thermal Conductivity Test Board for Leaded Surface Mount Packages". The standard describes the test method and board specifications for measuring the thermal resistance from junction to ambient. The actual thermal resistance for a particular application can vary depending on many factors, such as copper area and thickness. Refer to AN792, "A Method to Determine How Much Power a SOT23 Can Dissipate in an Application" (DS00792), for more information regarding this subject.

\[ T_{\text{J(RISE)}} = P_{\text{TOTAL}} \times R_{\theta \text{JA}} \]
\[ T_{\text{J(RISE)}} = 218.1 \text{ milli-Watts } \times 230.0^\circ \text{C/Watt} \]
\[ T_{\text{J(RISE)}} = 50.2^\circ \text{C} \]

Junction Temperature Estimate

To estimate the internal junction temperature, the calculated temperature rise is added to the ambient or offset temperature. For this example, the worst-case junction temperature is estimated below.

\[ T_{\text{J}} = T_{\text{J(RISE)}} + T_{A(\text{MAX})} \]
\[ T_{\text{J}} = 90.2^\circ \text{C} \]

Maximum Package Power Dissipation at +40°C Ambient Temperature

SOT23 (230.0°C/Watt = \(R_{\theta \text{JA}}\))

\[ P_{\text{D(MAX)}} = (125^\circ \text{C} - 40^\circ \text{C}) / 230^\circ \text{C/W} \]
\[ P_{\text{D(MAX)}} = 369.6 \text{ milli-Watts} \]

SOT89 (52°C/Watt = \(R_{\theta \text{JA}}\))

\[ P_{\text{D(MAX)}} = (125^\circ \text{C} - 40^\circ \text{C}) / 52^\circ \text{C/W} \]
\[ P_{\text{D(MAX)}} = 1.635 \text{ Watts} \]

TO92 (131.9°C/Watt = \(R_{\theta \text{JA}}\))

\[ P_{\text{D(MAX)}} = (125^\circ \text{C} - 40^\circ \text{C}) / 131.9^\circ \text{C/W} \]
\[ P_{\text{D(MAX)}} = 644 \text{ milli-Watts} \]

6.4  Voltage Reference

The MCP1700 can be used not only as a regulator, but also as a low quiescent current voltage reference. In many microcontroller applications, the initial accuracy of the reference can be calibrated using production test equipment or by using a ratio measurement. When the initial accuracy is calibrated, the thermal stability and line regulation tolerance are the only errors introduced by the MCP1700 LDO. The low cost, low quiescent current and small ceramic output capacitor are all advantages when using the MCP1700 as a voltage reference.

6.5  Pulsed Load Applications

For some applications, there are pulsed load current events that may exceed the specified 250 mA maximum specification of the MCP1700. The internal current limit of the MCP1700 will prevent high peak load demands from causing non-recoverable damage. The 250 mA rating is a maximum average continuous rating. As long as the average current does not exceed 250 mA, pulsed higher load currents can be applied to the MCP1700. The typical current limit for the MCP1700 is 550 mA (\(T_{A} +25^\circ \text{C}\)).
7.0 PackAGING INFORMATION

7.1 Package Marking Information

3-Pin SOT-23A

CKNN

3-Pin SOT-89

CUYYWWW

NNN

3-Pin TO-92

XXXXXX

XXXXXX

YWWNNN

Standard

<table>
<thead>
<tr>
<th>Symbol</th>
<th>Voltage</th>
</tr>
</thead>
<tbody>
<tr>
<td>CK</td>
<td>1.2</td>
</tr>
<tr>
<td>CM</td>
<td>1.8</td>
</tr>
<tr>
<td>CP</td>
<td>2.5</td>
</tr>
<tr>
<td>CR</td>
<td>3.0</td>
</tr>
<tr>
<td>CS</td>
<td>3.3</td>
</tr>
<tr>
<td>CU</td>
<td>5.0</td>
</tr>
</tbody>
</table>

Extended Temp

* Custom output voltages available upon request. Contact your local Microchip sales office for more information.

Example:

1700

1202E

313256

Legend: XX...X Customer specific information*

Y Year code (last digit of calendar year)

YY Year code (last 2 digits of calendar year)

WW Week code (week of January 1 is week ‘01’)

NNN Alphanumeric traceability code

Note: In the event the full Microchip part number cannot be marked on one line, it will be carried over to the next line thus limiting the number of available characters for customer specific information.

* Standard device marking consists of Microchip part number, year code, week code, and traceability code.
### 3-Lead Plastic Small Outline Transistor (TT) (SOT-23)

**Units**
- **INCHES**
- **MILLIMETERS**

<table>
<thead>
<tr>
<th>Dimension Limits</th>
<th>MIN</th>
<th>NOM</th>
<th>MAX</th>
<th>MIN</th>
<th>NOM</th>
<th>MAX</th>
</tr>
</thead>
<tbody>
<tr>
<td>Number of Pins</td>
<td>n</td>
<td>3</td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>Pitch</td>
<td>P</td>
<td>.038</td>
<td></td>
<td>.06</td>
<td></td>
<td></td>
</tr>
<tr>
<td>Outside lead pitch (basic)</td>
<td>P₁</td>
<td>.076</td>
<td></td>
<td></td>
<td>1.92</td>
<td></td>
</tr>
<tr>
<td>Overall Height</td>
<td>A</td>
<td>.035</td>
<td>.040</td>
<td>.044</td>
<td>.89</td>
<td>1.01</td>
</tr>
<tr>
<td>Molded Package Thickness</td>
<td>A₂</td>
<td>.035</td>
<td>.037</td>
<td>.040</td>
<td>.88</td>
<td>.95</td>
</tr>
<tr>
<td>Standoff §</td>
<td>A₁</td>
<td>.000</td>
<td>.002</td>
<td>.004</td>
<td>.01</td>
<td>.06</td>
</tr>
<tr>
<td>Overall Width</td>
<td>E</td>
<td>.083</td>
<td>.093</td>
<td>.104</td>
<td>2.10</td>
<td>2.37</td>
</tr>
<tr>
<td>Molded Package Width</td>
<td>E₁</td>
<td>.047</td>
<td>.051</td>
<td>.055</td>
<td>1.20</td>
<td>1.30</td>
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<tr>
<td>Overall Length</td>
<td>D</td>
<td>.110</td>
<td>.115</td>
<td>.120</td>
<td>2.80</td>
<td>2.92</td>
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<tr>
<td>Foot Length</td>
<td>L</td>
<td>.014</td>
<td>.016</td>
<td>.022</td>
<td>.35</td>
<td>.45</td>
</tr>
<tr>
<td>Foot Angle</td>
<td>θ</td>
<td>0</td>
<td>5</td>
<td>10</td>
<td>0</td>
<td>5</td>
</tr>
<tr>
<td>Lead Thickness</td>
<td>c</td>
<td>.004</td>
<td>.006</td>
<td>.007</td>
<td>.09</td>
<td>.14</td>
</tr>
<tr>
<td>Lead Width</td>
<td>B</td>
<td>.015</td>
<td>.017</td>
<td>.020</td>
<td>.37</td>
<td>.44</td>
</tr>
<tr>
<td>Mold Draft Angle Top</td>
<td>α</td>
<td>0</td>
<td>5</td>
<td>10</td>
<td>0</td>
<td>5</td>
</tr>
<tr>
<td>Mold Draft Angle Bottom</td>
<td>β</td>
<td>0</td>
<td>5</td>
<td>10</td>
<td>0</td>
<td>5</td>
</tr>
</tbody>
</table>

* *Controlling Parameter*

§ *Significant Characteristic*

**Notes:**
- Dimensions D and E1 do not include mold flash or protrusions. Mold flash or protrusions shall not exceed .010" (0.254mm) per side.
- JEDEC Equivalent: TO-236
- Drawing No. C04-104
3-Lead Plastic Small Outline Transistor Header (MB) (SOT-89)

<table>
<thead>
<tr>
<th>Units</th>
<th>INCHES</th>
<th>MILLIMETERS*</th>
</tr>
</thead>
<tbody>
<tr>
<td>Dimension Limits</td>
<td>MIN</td>
<td>MAX</td>
</tr>
<tr>
<td>Pitch</td>
<td>MIN</td>
<td>MAX</td>
</tr>
<tr>
<td>Outside lead pitch (basic)</td>
<td>.059 BSC</td>
<td>1.50 BSC</td>
</tr>
<tr>
<td>Overall Height</td>
<td>.055</td>
<td>.063</td>
</tr>
<tr>
<td>Overall Width</td>
<td>.155</td>
<td>.167</td>
</tr>
<tr>
<td>Molded Package Width at Base</td>
<td>.090</td>
<td>.102</td>
</tr>
<tr>
<td>Molded Package Width at Top</td>
<td>.084</td>
<td>.090</td>
</tr>
<tr>
<td>Overall Length</td>
<td>.173</td>
<td>.181</td>
</tr>
<tr>
<td>Tab Length</td>
<td>.064</td>
<td>.072</td>
</tr>
<tr>
<td>Foot Length</td>
<td>.035</td>
<td>.047</td>
</tr>
<tr>
<td>Lead Thickness</td>
<td>.014</td>
<td>.017</td>
</tr>
<tr>
<td>Lead 2 Width</td>
<td>.017</td>
<td>.022</td>
</tr>
<tr>
<td>Leads 1 &amp; 3 Width</td>
<td>.014</td>
<td>.019</td>
</tr>
</tbody>
</table>

*Controlling Parameter

Notes:
- Dimensions D and E1 do not include mold flash or protrusions. Mold flash or protrusions shall not exceed .005" (0.127mm) per side.
- JEDEC Equivalent: TO-243
- Drawing No. C04-29
3-Lead Plastic Transistor Outline (TO) (TO-92)

<table>
<thead>
<tr>
<th>Units</th>
<th>INCHES*</th>
<th>MILLIMETERS</th>
</tr>
</thead>
<tbody>
<tr>
<td>Number of Pins</td>
<td>n</td>
<td>3</td>
</tr>
<tr>
<td>Pitch</td>
<td>p</td>
<td>.050</td>
</tr>
<tr>
<td>Bottom to Package Flat</td>
<td>A</td>
<td>.130 .143 .155</td>
</tr>
<tr>
<td>Overall Width</td>
<td>E1</td>
<td>.175 .186 .195</td>
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<tr>
<td>Overall Length</td>
<td>D</td>
<td>.170 .183 .195</td>
</tr>
<tr>
<td>Molded Package Radius</td>
<td>R</td>
<td>.085 .090 .095</td>
</tr>
<tr>
<td>Tip to Seating Plane</td>
<td>L</td>
<td>.500 .555 .610</td>
</tr>
<tr>
<td>Lead Thickness</td>
<td>c</td>
<td>.014 .017 .020</td>
</tr>
<tr>
<td>Lead Width</td>
<td>B</td>
<td>.016 .019 .022</td>
</tr>
<tr>
<td>Mold Draft Angle Top</td>
<td>α</td>
<td>4 5 6</td>
</tr>
<tr>
<td>Mold Draft Angle Bottom</td>
<td>β</td>
<td>2 3 4</td>
</tr>
</tbody>
</table>

*Controlling Parameter

Notes:
Dimensions D and E1 do not include mold flash or protrusions. Mold flash or protrusions shall not exceed .010" (.254mm) per side.
JEDEC Equivalent: TO-92
Drawing No. C04-101
MCP1700

PRODUCT IDENTIFICATION SYSTEM

To order or obtain information, e.g., on pricing or delivery, refer to the factory or the listed sales office.

<table>
<thead>
<tr>
<th>PART NO.</th>
<th>X-</th>
<th>XXX</th>
<th>X</th>
<th>X</th>
<th>XX</th>
</tr>
</thead>
<tbody>
<tr>
<td>MCP1700</td>
<td>Tape &amp; Reel</td>
<td>Voltage Output</td>
<td>Tolerance</td>
<td>Temp. Range</td>
<td>Package</td>
</tr>
</tbody>
</table>

Device: MCP1700: Low Quiescent Current LDO

Tape and Reel: Tape and Reel only applies to SOT-23 and SOT-89 devices

Standard Output

<table>
<thead>
<tr>
<th>Voltage *</th>
</tr>
</thead>
<tbody>
<tr>
<td>120 = 1.2V</td>
</tr>
<tr>
<td>180 = 1.8V</td>
</tr>
<tr>
<td>250 = 2.5V</td>
</tr>
<tr>
<td>300 = 3.0V</td>
</tr>
<tr>
<td>330 = 3.3V</td>
</tr>
<tr>
<td>500 = 5.0V</td>
</tr>
</tbody>
</table>

* Custom output voltages available upon request. Contact your local Microchip sales office for more information

Tolerance: 2 = 2%

Temperature Range: E = -40°C to +125°C (Extended)

Package:

| TO = 3-lead TO-92 |
| MB = 3-lead SOT89 |
| TT = 3-lead SOT23 |

Examples:

TO-92 Package:

a) MCP1700-1202E/TO: 1.2V \( V_{OUT} \)
b) MCP1700-1802E/TO: 1.8V \( V_{OUT} \)
c) MCP1700-2502E/TO: 2.5V \( V_{OUT} \)
d) MCP1700-3002E/TO: 3.0V \( V_{OUT} \)
e) MCP1700-3302E/TO: 3.3V \( V_{OUT} \)
f) MCP1700-5002E/TO: 5.0V \( V_{OUT} \)

SOT89 Package:

a) MCP1700T-1202E/MB: 1.2V \( V_{OUT} \)
b) MCP1700T-1802E/MB: 1.8V \( V_{OUT} \)
c) MCP1700T-2502E/MB: 2.5V \( V_{OUT} \)
d) MCP1700T-3002E/MB: 3.0V \( V_{OUT} \)
e) MCP1700T-3302E/MB: 3.3V \( V_{OUT} \)
f) MCP1700T-5002E/MB: 5.0V \( V_{OUT} \)

SOT23 Package:

a) MCP1700T-1202E/TT: 1.2V \( V_{OUT} \)
b) MCP1700T-1802E/TT: 1.8V \( V_{OUT} \)
c) MCP1700T-2502E/TT: 2.5V \( V_{OUT} \)
d) MCP1700T-3002E/TT: 3.0V \( V_{OUT} \)
e) MCP1700T-3302E/TT: 3.3V \( V_{OUT} \)
f) MCP1700T-5002E/TT: 5.0V \( V_{OUT} \)

Sales and Support

Data Sheets

Products supported by a preliminary Data Sheet may have an errata sheet describing minor operational differences and recommended workarounds. To determine if an errata sheet exists for a particular device, please contact one of the following:

1. Your local Microchip sales office
2. The Microchip Corporate Literature Center U.S. FAX: (480) 792-7277
3. The Microchip Worldwide Site (www.microchip.com)

Please specify which device, revision of silicon and Data Sheet (include Literature #) you are using.

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